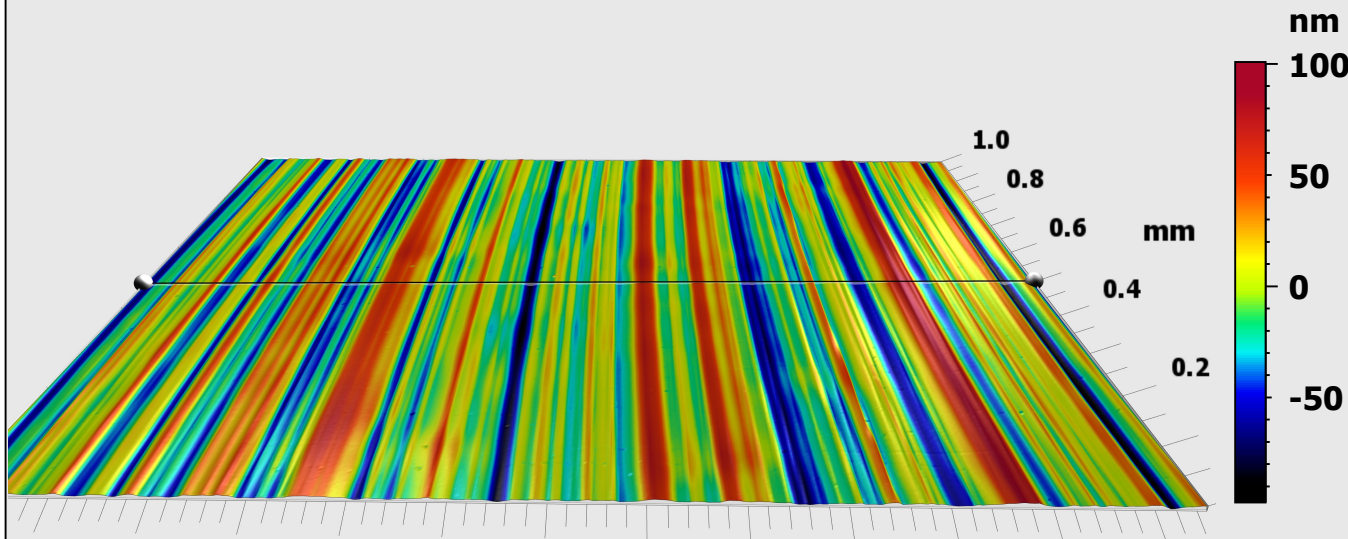


Ra - Height parameters - ISO 21920
24.13 nm

This result is not tracked

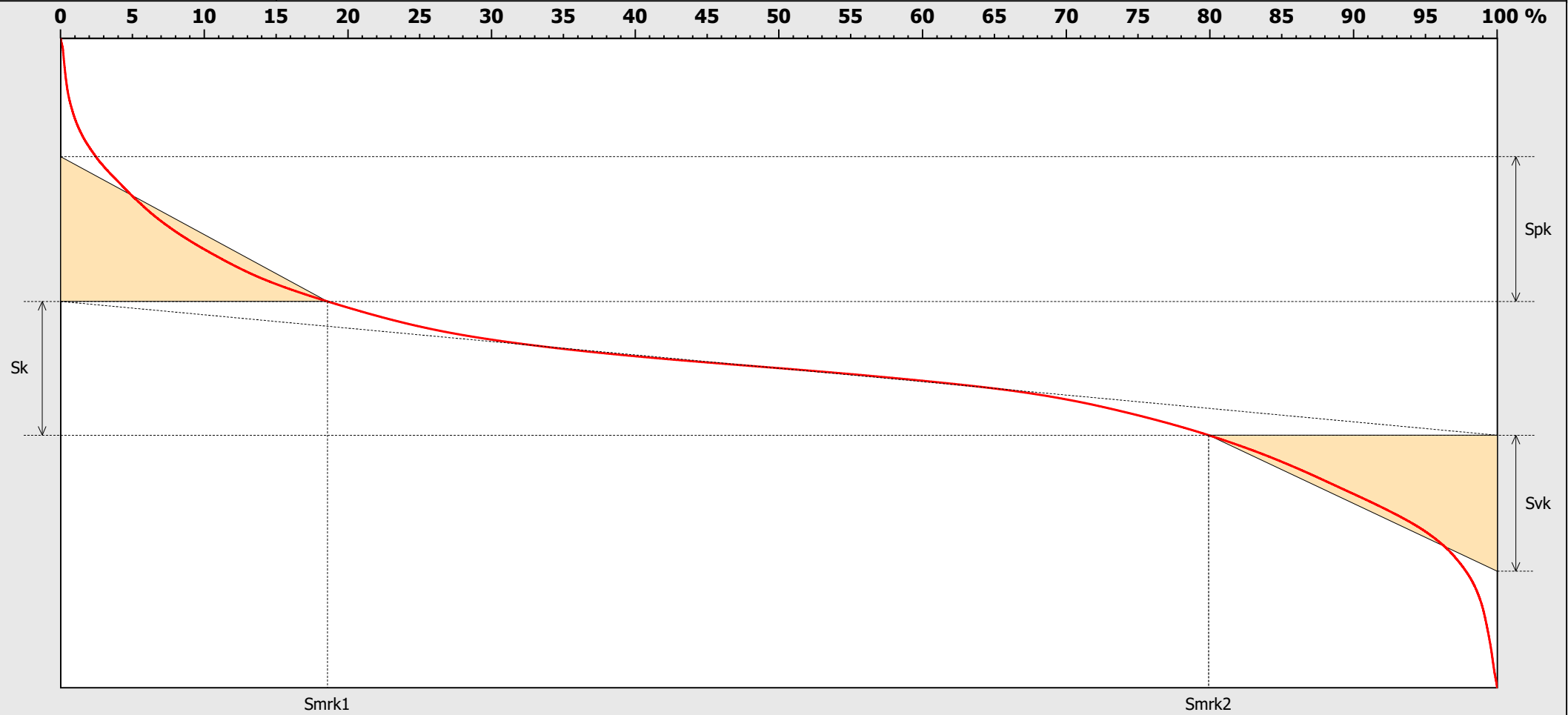
Rz - Height parameters - ISO 21920
128.3 nm

This result is not tracked

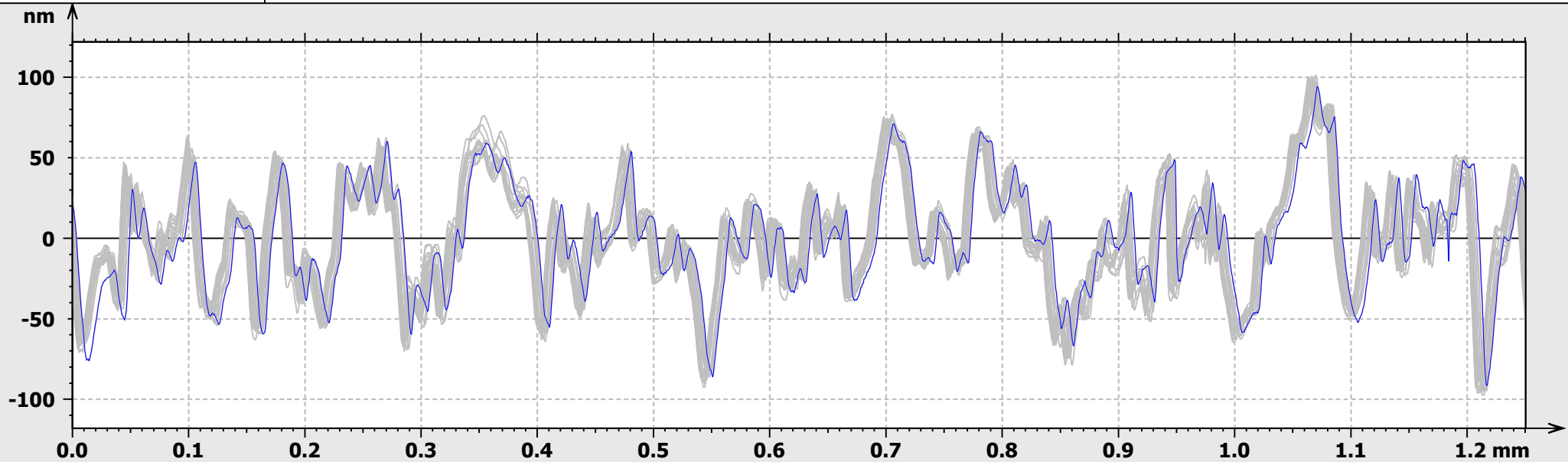


Rmax - Roughness profile parameters - Other profile parameters
170.3 nm

This result is not tracked



Parameters	Value	Unit
Sk	40.78	nm
Spk	44.13	nm
Svk	41.45	nm



Context		Mean	Std dev	Min	Max	
ISO 21920 - Roughness (S-L)						
<i>S-filter (λ_s): Gaussian, 2.5 μm</i>						
<i>F: None</i>						
<i>L-filter (λ_c): Gaussian, 0.25 mm</i>						
<i>Evaluation length: All λ_c (5)</i>						
Height parameters						
Rq	nm	29.98	0.2170	29.68	30.41	
Rz	nm	<i>Average of values on: All λ_c (5)</i>	129.7	127.9	132.4	
Ra	nm	24.16	0.1851	23.93	24.53	
Spatial parameters						
Ral	mm	<i>s = 0.2</i>	0.01343	0.0002229	0.01311	0.01394